RESPONSE TO COMMENTS ON PAPER ON GRAIN BOUNDARY SCATTERING MODEL FOR METALS

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The electrical conductivity of a polycrystalline metal film has been studied for a model in which the background scattering and grain boundary scattering are independent. The external surface electron scattering has been analyzed by assuming it to be independent of background scattering and thus the external surface scattering can be conveniently described with the Cottey method.

1. INTRODUCTION

An attempt has been recently made¹ to give a new model of electric conduction in thick metal films. Some points from this model are discussed by Tellier and Tosser.² The proposed model in paper 1 discussing scattering on grain boundary is similar to the Mayadas-Shatzkes model (Section 2). In Section 3 we shall prove, that to describe the external surface scattering in thin films we can use the Cottey method.

2. GRAIN BOUNDARY ELECTRON SCATTERING

In this Section we shall prove, that our model¹ of electron scattering on grain boundaries is similar to the Mayadas-Shatzkes model^{3,4} and we shall also demonstrate, that the electron transmission coefficient r has the value: $0 \leq r \leq 1$, similar to the electron reflection coefficient R at a grain boundary, which has also the value: $0 \leq R \leq 1$.

The conductivity for metal films⁴ in the presence of both grain-boundary and background scattering is found from

$$\sigma_g = \frac{e^2}{4\pi^3} \int \frac{\tau^* v^2}{|\nabla_k \epsilon|} dS_F \quad (1)$$

where

$$\tau^* = \frac{\tau}{1 + \frac{\alpha}{q}}; \quad \frac{1}{\tau^*} = \frac{1}{\tau} + \frac{1}{\tau} \alpha \frac{k_F}{|k_x|} \quad (2)$$

$$\alpha = \frac{ms^2 2\tau}{\hbar^3 dk_F} = \frac{\lambda}{D} \frac{R}{1 - R} \quad (3)$$

λ is the background mean free path, D is the average grain diameter, and R is the reflection coefficient

$$k_X = k_F |\cos \gamma| = k_F |\cos \Phi| |\sin \theta|, \\ q = \cos \gamma = \cos \Phi \sin \theta \quad (4)$$

where k_F – is the magnitude of the Fermi wavevector.

$$|\nabla_k \epsilon|^{-1} = \left(\frac{m}{2\hbar^2} \right)^{1/2} \epsilon^{-1/2} \quad (5)$$

$$dS_F = \frac{2m}{h^2} \epsilon_F \sin \theta d\theta d\Phi \quad (6)$$

Combining Eqs. (6), (5), (4), (3), (2), and Eq. (1), we obtain

$$\sigma_g = \frac{2e^2 m^2 v_F^3 \tau}{h^3} \int_0^{2\pi} d\Phi \int_0^\pi d\theta \frac{(\cos \Phi \sin \theta)^2 \sin \theta}{1 + \frac{\alpha}{|\cos \Phi| |\sin \theta|}} \quad (7)$$

Assuming that σ_0 is the conductivity in the absence of grain boundaries (bulk conductivity), we obtain

$$\sigma_0 = \frac{8\pi e^2 m^2 \tau v_F^3}{3h^3} \quad (8)$$

$$\frac{\sigma_g}{\sigma_0} = \frac{3}{4\pi} \int_0^{2\pi} d\Phi \int_0^\pi d\theta \frac{(\cos \Phi \sin \theta)^2 \sin \theta}{1 + \frac{\alpha}{|\cos \Phi| |\sin \theta|}} \equiv G(\alpha) \quad (9)$$

or

$$\frac{\sigma_g}{\sigma_0} = \frac{3}{4\pi} \int_0^{2\pi} d\Phi \int_0^\pi d\theta \frac{(\cos \Phi \sin \theta)^2 \sin \theta}{H(\Phi, \theta, \alpha)}$$

where

$$H(\Phi, \theta, \alpha) = 1 + \frac{\alpha}{|\cos \Phi| |\sin \theta|} \quad (9a)$$

Equation (9) has been obtained by Mayadas and Shatzkes⁴ by considering the total resistivity of a thin metal film in which three types of electron scattering mechanisms are simultaneously present: an isotropic background scattering, scattering due to a distribution of planar potentials grain boundaries, and scattering due to external surfaces. The intrinsic or bulk resistivity is obtained by solving the Boltzmann equation in which both grain-boundary and background scatterings are accounted for. The total resistivity is obtained by imposing boundary conditions due to the external surfaces as in the Fuchs^{5,6} theory using the Boltzmann equation.

Assuming that

$$\sigma_f = \frac{1}{Ea} \int_0^a dz \left\{ \frac{-2em^3}{h^3} \int v_x f(v) dv_x dv_y dv_z \right\} \quad (10)$$

and imposing boundary conditions, due to the external surface as in the Fuchs–Sondheimer theory^{5,6}, we obtain:

$$\begin{aligned} \sigma_f = \frac{1}{Ea} \int_0^a dz \left\{ - \frac{2e^2 m^2 E}{h^3} \int_0^\infty dv \int_0^{2\pi} d\Phi \int_0^{\pi/2} d\theta v^3 \cos^2 \Phi \right. \\ \left. \sin^3 \theta \tau^* \left[1 - \frac{1-p}{1-p \exp(-a/\tau^* v \cos \theta)} \right] \right. \\ \left. \times \exp \left(- \frac{z}{\tau^* v \cos \theta} \right) - \frac{2e^2 m^2 E}{h^3} \int_0^\infty dv \int_0^{2\pi} d\Phi \int_{\pi/2}^\pi \right. \\ \left. d\theta v^3 \cos^2 \Phi \sin^3 \theta \tau^* \left[1 - \frac{1-p}{1-p \exp(a/\tau^* v \cos \theta)} \right] \right. \\ \left. \exp \left(\frac{a-z}{\tau^* v \cos \theta} \right) \right\} \quad (11) \end{aligned}$$

Assuming that

$$\int_0^\infty v^3 \frac{\partial f_0}{\partial v} dv = -v_F^3; \quad k_F = \frac{k_x}{|\cos \Phi| |\sin \theta|}; \quad \tau v = \lambda \quad (12)$$

$$\frac{1}{\tau^*} = \frac{1}{\tau} + \frac{1}{\tau} \frac{\alpha}{|\cos \Phi| |\sin \theta|}; \quad \tau^* = \frac{\tau}{H(\Phi, \theta, \alpha)} \quad (13)$$

where

$$H(\Phi, \theta, \alpha) = 1 + \frac{\alpha}{|\cos \Phi| |\sin \theta|}$$

the Eq. (11) becomes

$$\begin{aligned} \sigma_f = \frac{4e^2 m^2 v_F^3 \tau}{h^3} \int_0^{2\pi} d\Phi \int_0^{\pi/2} d\theta \frac{\cos^2 \Phi \sin^3 \theta}{H(\Phi, \theta, \alpha)} \\ + - \frac{4e^2 m^2 v_F^3 \tau}{h^3} \frac{\lambda}{a} (1-p) \int_0^{2\pi} d\Phi \int_0^{\pi/2} d\theta \\ \frac{\cos^2 \Phi \sin^3 \theta \cos \theta}{H^2(\Phi, \theta, \alpha)} \frac{1 - \exp \left(- \frac{aH(\Phi, \theta, \alpha)}{\lambda \cos \theta} \right)}{1 - p \exp \left(- \frac{aH(\Phi, \theta, \alpha)}{\lambda \cos \theta} \right)} \quad (14) \end{aligned}$$

Considering Eq. (8)

$$\begin{aligned} \frac{\sigma_f}{\sigma_0} = \frac{3}{2\pi} \int_0^{2\pi} d\Phi \int_0^{\pi/2} d\theta \frac{\cos^2 \Phi \sin^3 \theta}{H(\Phi, \theta, \alpha)} - \frac{3}{2\pi} \frac{\lambda}{a} \\ \times (1-p) \int_0^{2\pi} d\Phi \int_0^{\pi/2} d\theta \frac{\cos^2 \Phi \sin^3 \theta \cos \theta}{H^2(\Phi, \theta, \alpha)} \\ \times \frac{1 - \exp \left(- \frac{aH(\Phi, \theta, \alpha)}{\lambda \cos \theta} \right)}{1 - p \exp \left(- \frac{aH(\Phi, \theta, \alpha)}{\lambda \cos \theta} \right)} \quad (15) \end{aligned}$$

The first term on the right hand side of Eq. (15) is the grain boundary scattering function (Eq. (9)). The equation (15) is often described as

$$\frac{\sigma_f}{\sigma_0} = G(\alpha) - A(k, p, \alpha) \quad (16)$$

$G(\alpha)$ is a grain-boundary function and can be expressed by Eq. (9) or by Eq. (1). Considering that

$$\cos \Phi \sin \theta = \cos \gamma = q,$$

(see Figure 1) and Eq. (2), we have that Eq. (9) can be transformed to

$$\frac{\sigma_g}{\sigma_0} = \frac{3}{2} \frac{1}{\tau} \int_{-1}^1 \tau^*(q) q^2 dq = 3 \int_0^1 \frac{q^3}{\alpha + q} dq \quad (17)$$

Eq. (17) was also obtained by Mayadas and Shatzkes.^{3,4}

The solution of the integral in Eq. (17) includes the following expression

$$\frac{\sigma_g}{\sigma_0} = 1 - \frac{3}{2}\alpha + 3\alpha^2 - 3\alpha^3 \ln \left(1 + \frac{1}{\alpha} \right) \equiv G(\alpha) \quad (18)$$

Let us examine the equations (9) and (17), because these equations refer to electrical conductivity for the film, for which we consider the background scattering and the grain boundary scattering. The model given in paper¹ considers similar problems and as it will be further shown, the effects of electron scattering can also be calculated by means of Matthiessen's rule starting

FIGURE 1 Geometry of the scattering planes model

from the electron mean free path related to a particular type of scattering (bulk and grain boundaries). Similarly, considering that¹

$$\frac{1}{\tau^*(D, r)} = \frac{1}{\tau} + \frac{1}{\tau_D} \quad (19)$$

where

$$\tau_D = \frac{D}{v_F |\cos \Phi \sin \theta| \ln 1/r} \quad (20)$$

D is the average grain diameter (i.e. $D = \sum_i d_i/n$)

$$V_X = V_F \cos \Phi \sin \theta = V_F \cos \gamma \quad (\text{see Fig. 1}) \quad (21)$$

we obtain

$$\tau^*(D, r) = \frac{\tau}{1 + \frac{|\cos \Phi \sin \theta|}{v}} \quad (22)$$

where

$$v = \frac{D}{\lambda \ln 1/r}; \quad \lambda = \tau v_F \quad (23)$$

Considering the relation

$$\sigma_g = -\frac{2em^3}{Eh^3} \int v_x f_1 dv_x dv_y dv_z \quad (24)$$

and the Boltzmann equation

$$\frac{f_1}{\tau^*(D, r)} = \frac{eE}{m} \frac{\partial f_0}{\partial v_x} \quad (25)$$

we obtain

$$\frac{\sigma_g}{\sigma_0} = \frac{3}{4\pi} \int_0^{2\pi} d\Phi \int_0^\pi d\theta \frac{(\cos \Phi \sin \theta)^2 \sin \theta}{1 + \frac{|\cos \Phi \sin \theta|}{v}} \equiv F(v) \quad (26)$$

For the cylindrical grain boundaries, Eq. (26) assumes a simple form and was derived previously.^{1,7} Comparing Eqs. (26) and (9), we obtain

$$\frac{\cos \Phi \sin \theta}{v} \sim \frac{\alpha}{\cos \Phi \sin \theta} \quad (27)$$

Considering that^{3,4}

$$\alpha = \frac{\lambda}{D} \frac{R}{1-R} \quad (28)$$

and^{1,7}

$$v = \frac{D}{\lambda \ln 1/r} \quad (29)$$

we obtain

$$\frac{R}{1-R} \sim \cos^2 \Phi \sin^2 \theta \ln 1/r \quad (30)$$

As $0 \leq R \leq 1$ thus also $0 \leq r \leq 1$. Similarly we have^{3,4}

$$\alpha = \frac{m}{\hbar^3 d} \frac{s^2 2\tau}{k_F} = \frac{m}{\hbar^3 d} \frac{s^2 2\tau}{k_x} \cos \Phi \sin \theta \quad (31)$$

and

$$v \sim \frac{\cos^2 \Phi \sin^2 \theta}{\alpha} \sim \left(\frac{m}{\hbar^3 d} \frac{s^2 2\tau}{k_x} \right)^{-1} \cos \Phi \sin \theta \quad (32)$$

If no electrons are travelling through the grain boundary then $r = 0$ ($R = 1$). If all electrons pass the grain boundary, then $r = 1$ ($R = 0$). If we introduce Eq. (32) into Eq. (26), then we obtain Eq. (9) or Eq. (17). This is the Mayadas-Shatzkes expression. Tellier and Tosser² assume that the proposed model is true only for $r \approx 1$. As it been shown above, Eq. (26) is valid if r takes any value in the range $0 \leq r \leq 1$. Considering Eqs. (1) and (22) and $q = \cos \Phi \sin \theta$, we obtain

$$\sigma_g = \frac{e^2}{4\pi^3} \int \frac{\tau^*(D, r) v_x^2}{|\nabla_k \epsilon|} dS_F = 3\sigma_0 v \int_0^1 \frac{q^2}{v+q} dq \quad (33)$$

Integration of Eq. (33) gives

$$\frac{\sigma_g}{\sigma_0} = \frac{3}{2}v - 3v^2 + 3v^3 \ln \left(1 + \frac{1}{v} \right) \equiv F(v) \quad (34)$$

Eq. (34) reduces to the approximate expressions for the large grain and for the very thin grain respectively.

$$\frac{\sigma_g}{\sigma_0} = 1 - \frac{3}{4\nu} + \frac{1}{5\nu^2} - \dots \quad \text{for } \nu > 1$$

$$\frac{\sigma_g}{\sigma_0} = \frac{3}{2}\nu - 3\nu^2 + \dots \quad \text{for } \nu < 1$$

and

$$\frac{\sigma_g}{\sigma_0} = 0.5793 \quad \text{for } \nu = 1 \quad (35)$$

Thus it would seem that the new model proposed recently¹ is valid and the expressions for the Mayadas-Shatzkes equation (Eq. (9) and Eq. (17)), together with the alternative expressions (Eq. (26) and Eq. (33)), respectively are relatively simple.²

Recently, Tellier and Tosser⁸ have reported a statistical model for thin metallic films in which the grain boundaries are perpendicular to the x-direction and y-direction, assuming that the transmission coefficient (denoted by t in their papers) can assume values less than unity. Such a statistical model is a special case of the present model (Eq.(26)).

3. EXTERNAL SURFACE ELECTRON SCATTERING

Let us consider both the Fuchs method^{5,6} and the Cottey method⁹ used to describe electrical conductivity for metallic films in which the background electron scattering and the external surface scattering are examined. The surface reflection parameter p will be discussed in detail. We consider some of the assumptions made by Fuchs^{5,6} and the present author, to describe the external size-effect. The Fuchs theory assumes that the relaxation time of bulk material is independent of the film thickness and the p_{Fuchs} parameter.

$$f_1 = f_1(t=0)\exp\left(-\frac{t}{\tau}\right); \quad \tau = \text{const} \quad (36)$$

where the function f_1 depends on the space variables only through z .

$$\frac{\partial f_1}{\partial z} \neq 0 \quad (37)$$

The boundary conditions at the surfaces of the film are described in general, as follows

$$f_1(v_z, z) = p_F f_1(-v_z, z) \quad (38)$$

The electric field E is supposed to be in the x-direction and the Boltzmann equation reduces to

$$\frac{\partial f_1}{\partial z} + \frac{f_1}{\tau v_z} = \frac{eE}{mv_z} \frac{\partial f_0}{\partial v_x} \quad (39)$$

Carrying out an integration over z , we obtain for the effective conductivity of the film

$$\sigma_f = \frac{1}{Ea} \int_0^a dz \left\{ -\frac{2em^3}{h^3} \int v_x f_1 dv_x dv_y dv_z \right\} \quad (40)$$

In our model^{8,9} of the electron surface scattering we consider that

$$f_1 = f_1(t=0)\exp\left(-\frac{t}{\tau(a,p)}\right); \quad \tau(a,p) \neq \text{const} \quad (41)$$

and

$$\frac{\partial f_1}{\partial z} = 0 \quad (42)$$

This term is neglected in the Boltzmann equation. We assume, that the external surface scattering and background scattering are independent and the relaxation time $\tau(a,p)$ for both scatterings equals:

$$\frac{1}{\tau(a,p)} = \frac{1}{\tau} + \frac{1}{\tau_a} \quad (43)$$

Hence the theoretical expression for $\tau(a,p)$ is

$$\tau(a,p) = \frac{\tau a}{a + \tau \ln\left(\frac{1}{p}\right) v_F \cos \theta} \quad (44)$$

The p -parameter can also be conveniently described by the Cottey model, p_{Cottey} .

If there is an electric field, E , in the x-direction, the linearized Boltzmann equation is

$$\frac{f_1}{\tau(a,p)} = \frac{eE}{m} \frac{\partial f_0}{\partial v_x} \quad (45)$$

and the conductivity of the film is found to be

$$\sigma_f = -\frac{2em^3}{Eh^3} \int v_x f_1 dv_x dv_y dv_z \quad (46)$$

In general, the parameter $p_{\text{Fuchs}} = p_{\text{Cottey}}$ if p_{Fuchs} is near 1 and p_{Cottey} is near 1. We, however, are concerned with $0 \leq p_{\text{Fuchs}} \leq 1$ and $0 \leq p_{\text{Cottey}} \leq 1$. The Fuchs parameter is the probability that an electron will be specularly reflected upon scattering from a film surface. Our parameter p is the probability that an electron will be reflected upon scattering from a film surface. If $p_{\text{Fuchs}} = 0$, then all the models agree for diffuse scattering⁶—for example:

$$\sigma_f = \sigma_0 \left\{ 1 - \frac{3}{8} \frac{\lambda}{a} + \frac{3}{2} \frac{\lambda}{a} \int_0^{\pi/2} \sin \theta (\cos^3 \theta - \cos^5 \theta) \exp\left(-\frac{a}{\lambda \cos \theta}\right) d\theta \right\} \quad (47)$$

If $p = 0$, in our model no conduction electrons are reflected from an external film surface and the film conductivity σ_f equals zero.

Considering the background, grain-boundary and external-surface scatterings in our model, we obtain

$$\frac{\sigma_f}{\sigma_0} = \frac{3}{4\pi} \int_0^{2\pi} d\Phi \int_0^\pi d\theta \frac{\cos^2 \Phi \sin^3 \theta}{1 + \frac{|\cos \theta|}{\mu} + \frac{|\cos \Phi| \sin \theta}{\nu}} \quad (49)$$

where

$$\mu = \frac{a}{\lambda \ln 1/p}; \quad \nu = \frac{D}{\lambda \ln 1/r}$$

This integral has been calculated explicitly for cylindrical grain boundaries.¹⁰

Recently a three-dimensional model of grain boundaries has been proposed by Pichard, Tellier and Tosser.¹¹ This is an extension of the present grain scattering model since it is possible that the reflection

parameter p , and the transmission coefficient t can assume values less than unity. This contrasts with previous comments² (see also Refs. 11 and 12).

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